

## 3-Vrms Cap-Less Line Driver with Adjustable Gain

#### **Features**

- Operation Voltage: 3V to 5.5V
- Cap-less Output
  - Eliminates Output Capacitors
  - Improves Low Frequency Response
  - Reduces POP/Clicks
- Low Noise and THD
  - SNR > 102dB
  - Typical Vn < 12uVrms
  - THD+N < 0.02%
- Maximum Output Voltage Swing into 2.5k Load
  - 2Vrms at 3.3V Supply Voltage
  - 3Vrms at 5V Supply Voltage
- single-ended Input
- External Gain Setting from 1V/V to 10V/V
- Fast Start-up Time : 0.5ms
- Integrated De-Pop Control
- Thermal Protection
- Less External Components Required
- +/-8kV IEC ESD Protection at line outputs

# Ordering Information Applications

- LCD / PDP TVs
- CD / DVD players
- Set-Top Boxes
- Home Theater in Box

### **Description**

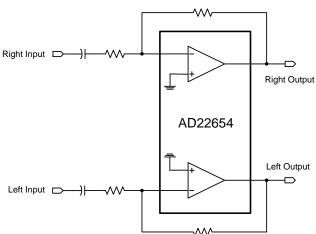
The AD22654 is a 3-Vrms cap-less stereo line driver. The device is ideal for single supply electronics. Cap-less design can eliminate output dc-blocking capacitors for better low frequency response and save cost.

The AD22654 is capable of delivering 3-Vrms output into a  $2.5 k\Omega$  load with 5V supply. The gain settings can be set by users from 1V/V to 10V/V externally. The AD22654 is Build-in shutdown control and de-pop control sequence also help AD22654 to be a pop-less device.

The AD22654 is available in a 10-pin MSOP package.

	Product ID	Package	Packing	Comments
	AD22654-MH10NAT		80 Units / Tube	
	AD22034-WITTONAT	MSOP-10	100 Tubes / Small Box	Green(HF)
ĺ	AD22654-MH10NAR		3k Units Tape & Reel	

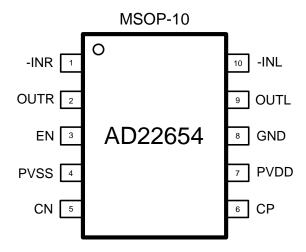
## **Simplified Application Circuit**



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# **Pin Assignments**



## **Pin Description**

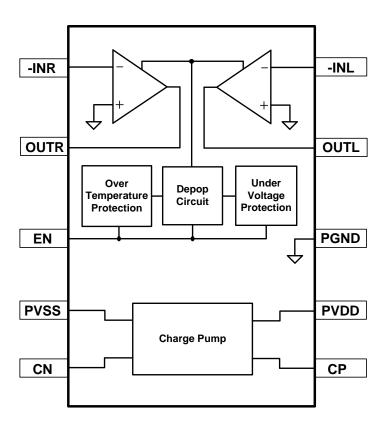
No.	Name	Type <sup>(1)</sup>	Pin Description
1	-INR	I	Right channel OP negative input
2	OUTR	0	Right channel OP output
3	EN	I	Enable input, active high
4	PVSS	Р	Supply voltage
5	CN	I/O	Charge-pump flying capacitor negative terminal
6	СР	I/O	Charge-pump flying capacitor positive terminal
7	PVDD	Р	Positive supply
8	GND	Р	Ground
9	OUTL	0	Left channel OP output
10	-INL	I	Left channel OP negative input

<sup>(1)</sup> I=input, O=output, P=power

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## **Functional Block Diagram**



**Available Package** 

Package Type	Device No.	<b>Θ</b> <sub>ja</sub> (℃/W) <sup>(1)</sup>	<b>Θ</b> <sub>jc</sub> (°C/W) <sup>(2)</sup>
MSOP-10	AD22654	120	45

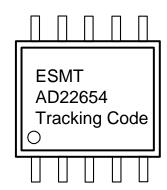
<sup>(1)</sup>  $\Theta_{ja}$  is measured at room temperature (TA=25°C), natural convection environment test board, which is constructed with a thermal efficient, 2-layers PCB. The measurement is tested using the JEDEC51-3 thermal measurement standard.

# **Marking Information**

AD22654

Line 1: LOGO

Line 2 : Product No.
Line 3 : Tracking Code



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<sup>(2)</sup>  $\Theta_{jc}$  represents the heat resistance for the heat flow between the chip and package's top surface.



**Absolute Maximum Ratings** (1)

SYMBOL	PARAMETER	VALUE	UNIT
	Supply Voltage, V <sub>DD</sub> to GND	-0.3 to 6.0	V
V <sub>I</sub>	Input Voltage	VSS -0.3 to VDD+0.3	V
$R_L$	Minimum load impedance	> 600	Ω
	EN to GND	-0.3 to VDD+0.3	V
T <sub>stg</sub>	Storage temperature range	-65 to 150	$^{\circ}\!\mathbb{C}$
TJ	Maximum operating junction temperature range	-40 to 150	$^{\circ}\!\mathbb{C}$

<sup>(1)</sup> The absolute maximum ratings are limiting values of operation, safety of the device cannot be guaranteed if beyond those values.

**Recommended Operating Conditions** 

SYMBOL	PARAMETER		Min	NOM	Max	UNIT
V <sub>DD</sub>	Supply Voltage		3.0		5.5	V
V <sub>IH</sub>	High Level Input Voltage EN			60		% of $V_{\text{DD}}$
$V_{IL}$	Low Level Input Voltage EN			40		% of $V_{\text{DD}}$
T <sub>A</sub>	Operating Ambient Temperature Range		-40		85	$^{\circ}\!\mathbb{C}$
$R_L$	Load Resistance		600			Ω

#### **Electrical Characteristics**

SYMBOL	PARAMETER	TEST CONDITIONS	Min	NOM	Max	UNIT
I <sub>DD</sub>	V <sub>DD</sub> Supply Current	EN=V <sub>DD</sub>		7	15	mA
I <sub>SD</sub>	V <sub>DD</sub> Shutdown Current	EN=0V, V <sub>DD</sub> =5.5V			5	μΑ
II	Input Current	EN pin		0.1		μΑ
	Output Valtage	THD+N=1%, $V_{DD}$ =3.3V, $f_{IN}$ =1kHz		2.2		
Vo	Output Voltage (Outputs In Phase)	THD+N=1%, V <sub>DD</sub> =5V, f <sub>IN</sub> =1kHz		3.4 V		Vrms
	(Outputs III Friase)	THD+N=1%, V <sub>DD</sub> =5V, f <sub>IN</sub> =1kHz, RL=100k		3.5		
THD+N	Total Harmonic Distortion Plus Noise	V <sub>O</sub> =2Vrms, f <sub>IN</sub> =1kHz		0.002		%
Crosstalk	Channel Separation	V <sub>O</sub> =2Vrms, f <sub>IN</sub> =1kHz		-110		dB
$V_N$	Output Noise	R <sub>I</sub> =10k, R <sub>F</sub> =10k		11	15	μVrms

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# **Electrical Characteristics (Con't)**

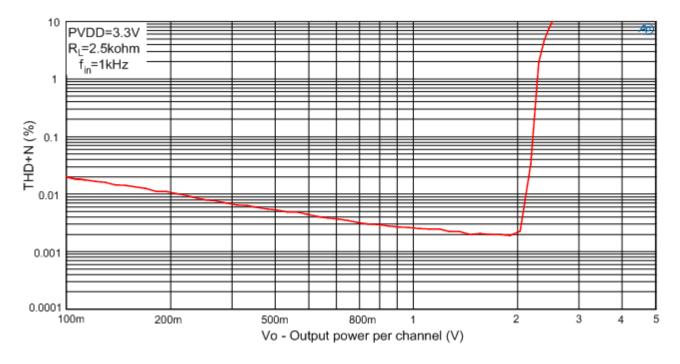
SYMBOL	PARAMETER	TEST CONDITIONS	Min	NOM	Max	UNIT
$V_{SR}$	Slew Rate			8		V/µs
SNR	Signal to Noise Ratio	$V_0$ =2Vrms, $R_I$ =10k, $R_F$ =10k, A-weighted		107		dB
$G_{BW}$	Unit-Gain Bandwidth			8		MHz
A <sub>VO</sub>	Open-Loop Gain		80			dB
Vos	Output Offset Voltage	V <sub>DD</sub> =3V to 5.5V, Input Grounded	-5		5	mV
PSRR	Power Supply Rejection Ratio	$V_{DD}$ =3V to 5.5V, $V_{rr}$ =200mVrms, $f_{IN}$ =1kHz		-80	-60	dB
Rı	Input Resistor Range		1	10	47	kΩ
R <sub>F</sub>	Feedback Resistor Range		4.7	20	100	kΩ
f <sub>CP</sub>	Charge-Pump Frequency		400	500	600	kHz
	Maximum capacitive Load			220		pF
TSD	Over Temperature Protection Level			150		$^{\circ}$
T <sub>start-up</sub>	Start-up Time			0.5		ms

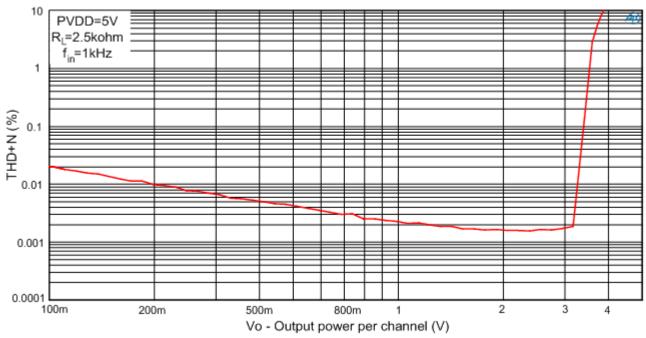
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## **Typical Characteristics**

• Total Harmonic Distortion + Noise (THD+N) vs. Output Power

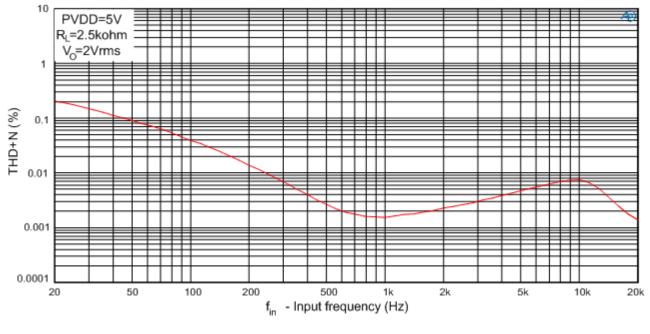


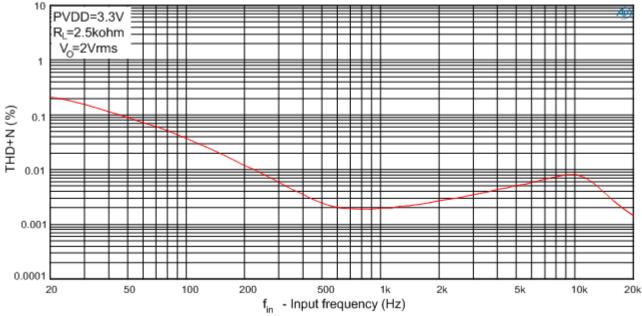


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• Total Harmonic Distortion + Noise (THD+N) vs. Signal Frequency

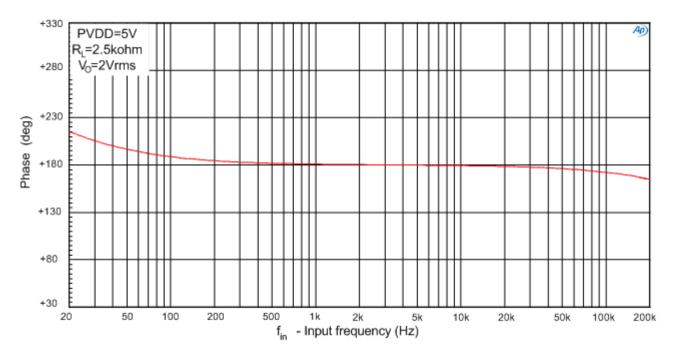




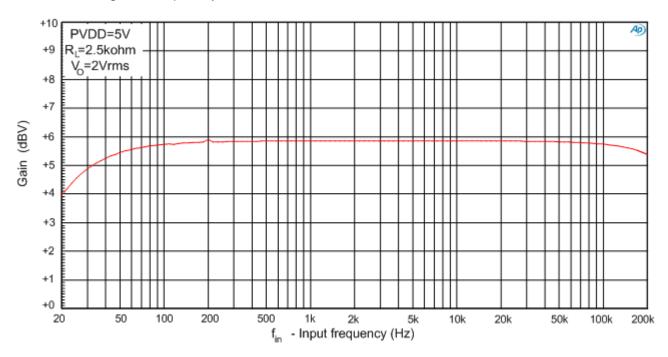
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## • Phase vs. Signal Frequency



## • Gain vs. Signal Frequency



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## **Application Information**

#### **■** Line Driver Amplifiers Operation

A conventional inverting line-driver amplifier always requires an output dc-blocking capacitor and a bypass capacitor, see Figure 1. DC blocking capacitors are large in size and cost a lot. It also restricts the output low frequency response. POP will occur if the charge and discharge processes on output capacitors are not carefully take cared. Besides, it needs to wait for a long time to charge V<sub>OUT</sub> from 0V to VDD/2.

For a cap-less line driver, see figure 2, a negative supply voltage (-VDD) is produced by the integrated charge-pump, and feeds to line driver's negative supply instead of ground. The positive input can directly connect to ground without a  $C_{BYPASS}$ , and  $V_{OUT}$  is biased at ground which can eliminate the output dc-blocking capacitors. The output voltage swing is doubled compared to conventional amplifiers.

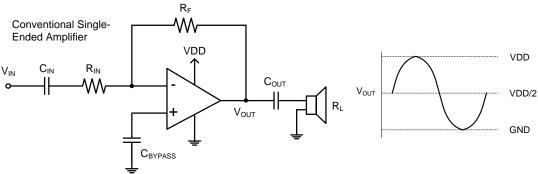


Figure 1. Conventional Line Driver Amplifier

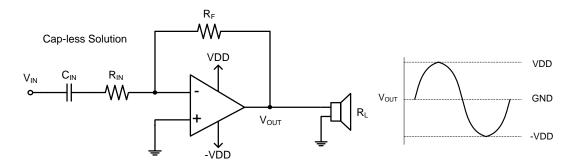


Figure 2. Cap-less Line Driver Amplifier

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#### Charge-Pump Operation

The charge-pump is used to generate a negative supply voltage to supply to line-driver. It needs two external capacitors, C<sub>FLY</sub> and C<sub>PVSS</sub>, for normal operation, see figure 3 (a). The operation can be analyzed with two phase. In phase I, see figure 3 (b), CFLY is charged to PVDD, and in phase II, see figure 3 (c), the charges on C<sub>FLY</sub> are shared with C<sub>PVSS</sub>, that makes PVSS a negative voltage. After an adequate clock cycles, PVSS will be equaled to -PVDD. Low ESR capacitors are recommended, and the typical value of  $C_{\text{FLY}}$  and  $C_{\text{PVSS}}$  is  $1\mu\text{F.}$  A smaller capacitance can be used, but the maximum output voltage may be reduced.

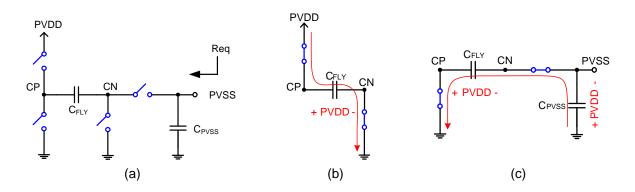


Figure 3. Charge-Pump Operation

#### **Enable Function**

The enable function is used to reduce power consumption while the device is not in use. When a logic low is applied to this pin, the overall circuits are turned off. Line driver output and PVSS are pulled to ground. When a logic high is applied to enable pin, the PVSS is started to build-up and line driver output signal is released after about 0.5ms typically.

#### **Decoupling Capacitors**

A low ESR power supply decoupling capacitor is required for better performance. The capacitor should place as close to chip as possible, the value is typically 1µF. For filtering low frequency noise signals, a 10µF or greater capacitor placed near the chip is recommended.

#### Input Blocking Capacitors (C<sub>IN</sub>)

An input blocking capacitor is required to block the dc voltage of the audio source and allows the input to bias at a proper dc level for optimum operation. The input capacitor and input resistor (R<sub>I</sub>) form a high-pass filter with the corner frequency determined as following equation:

$$f_C = \frac{1}{2\pi R_I C_{IV}}$$



#### ■ Gain Setting Resistors (R<sub>I</sub> and R<sub>F</sub>)

The line driver's gain is determined by  $R_I$  and  $R_F$ . The configuration of the amplifier is inverting type, see figure 4. The gain equation is listed as follows:

Inverting configuration:  $A_V = -\frac{R_F}{R_I}$ 

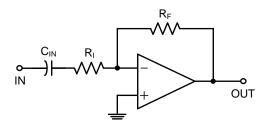


Figure 4. Line Driver Amplifier Configurations

The values of  $R_I$  and  $R_F$  must be chosen with consideration of stability, frequency response and noise. The recommended value of  $R_I$  is in the range from  $1k\Omega$  to  $47k\Omega$ , and  $R_F$  is from  $4.7k\Omega$  to  $100k\Omega$  for. The gain is in the range from -1V/V to -10V/V for inverting configuration. Table 1 lists the recommended resistor values for different configurations.

$R_i(k\Omega)$	$R_F(k\Omega)$	Inverting Input Gain (V/V)
22	22	-1
15	30	-2
33	68	-2.1
10	100	-10

Table 1. Recommended Resistor Values

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#### ■ Second-Order Filter Configuration

AD22654 can be used like a standard OPAMP. Several filter topologies can be implemented by using AD22654, single-ended input configuration, see figure 5. For inverting input configuration, the overall gain is  $-\frac{R2}{R1}$ , the high-pass filter's cutoff frequency is  $\frac{1}{2\pi R1C3}$ , the low-pass filter's cutoff frequency

is  $\frac{1}{2\pi\sqrt{R2R3C1C2}}$  , The detail component values are listed on table 2.

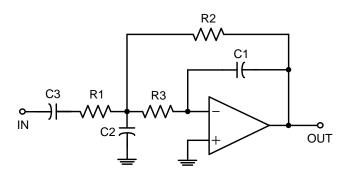


Figure 5. Second-order Active Low-Pass Filter

Gain (V/V)	High Pass (Hz)	Low Pass (kHz)	C1 (pF)	C2 (pF)	C3 (µF)	R1 (kΩ)	R2 (kΩ)	R3 (kΩ)
-1	1.6	40	100	680	10	10	10	24
-1.5	1.3	40	68	680	15	8.2	12	30
-2	1.6	60	33	150	6.8	15	30	47
-2	1.6	30	47	470	6.8	15	30	43
-3.33	1.2	30	33	470	10	13	43	43
-10	1.5	30	22	1000	22	4.7	47	27

Table 2. Second-order Low-Pass Filter Specifications

#### Over-Temperature Protection

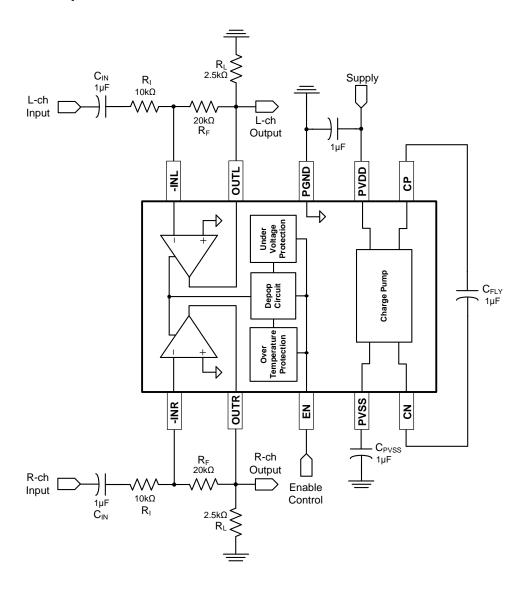
AD22654 provide an over-temperature protection to limit the junction temperature to  $150^{\circ}$ C. As junction temperature exceeds  $150^{\circ}$ C, internal thermal sensor will turn off the drivers immediately. The drivers will turn on again if the junction temperature is smaller than  $130^{\circ}$ C. A  $20^{\circ}$ C hysteresis is designed to lower the average junction temperature during continuous thermal overload conditions, increasing lifetime of the chip.

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# **Typical Application Circuit**

## ■ Line Driver Amplifier

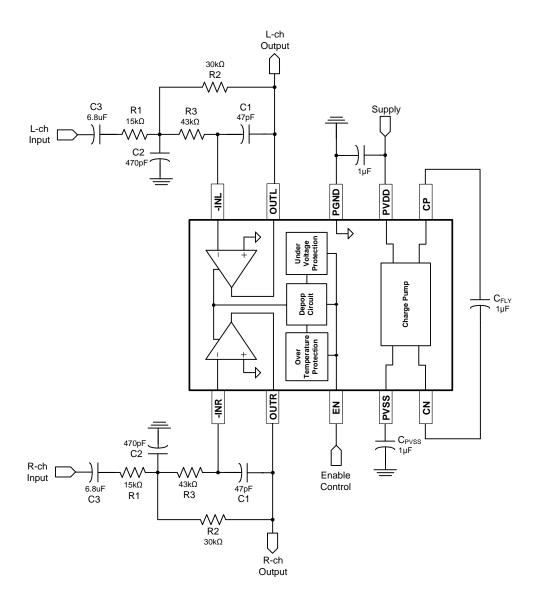


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# **Typical Application Circuit (cont.)**

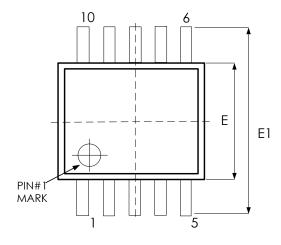
■ Second-Order Active Low-Pass Filter (load support >= 600Ω only)

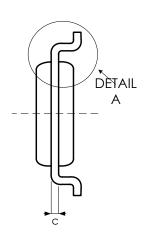


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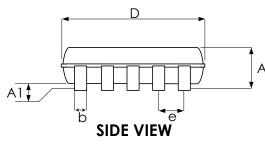


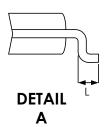
# Package Outline Drawing MSOP-10











Cryss la o l	Dimensio	on in mm		
Symbol	Min	Max		
A	0.81	1.10		
A1	0.00	0.15		
Ъ	0.17	0.33		
С	0.08	0.23		
D	2.90	3.10		
Е	2.90	3.10		
E1	4.80	5.00		
е	0.50 BSC			
L	0.40	0.80		



# **Revision History**

Revision	Date	Description
1.0	2012.09.25	Original
1.1	2012.12	Modify the Pin Description and Package Outline Drawing
1.2	2013.07	Modify ISD max spec from 100uA to 5uA with VDD =5.5V
1.3	2014.01.29	Modify TA from 0~70'C to -40~85'C
1.4	2018.01.03	Update typical application circuit.
1.5	2018.04.13	Update features page 1.

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